

Search Notes

Application/Control No.

10/622,606

Examiner

Thien F. Tran

Applicant(s)/Patent under
Reexamination

COUILLARD ET AL.

Art Unit

2811

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Interference search history printout	2/3/2006	TT